

USB1T20 Universal Serial Bus Transceiver

General Description

The USB1T20 is a generic USB 2.0 compliant transceiver. Using a single voltage supply, the USB1T20 provides an ideal USB interface solution for any electronic device able to supply 3.0V to 3.6V. It is designed to allow 5.0V or 3.3V programmable and standard logic to interface with the physical layer of the Universal Serial Bus. It is capable of transmitting and receiving serial data at both full speed (12Mbit/s) and low speed (1.5Mbit/s) data rates.

Packaged in industry standard TSSOP and Fairchild's ultra-small 2.5mm x 2.5mm MLP package, the USB1T20 is ideal for ultra-portable electronics and other space constrained applications.

Features

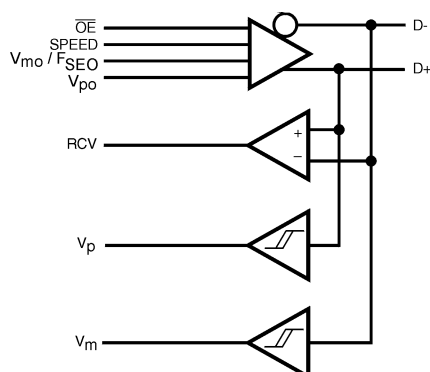
- Complies with Universal Serial Bus specification 2.0 for FS/LS applications
- Utilizes digital inputs and outputs to transmit and receive USB cable data
- Supports 12Mbit/s "Full Speed" and 1.5Mbit/s "Low Speed" serial data transmission
- Supports single-ended and differential data interface as function of MODE
- Single 3.3V supply
- ESD Performance: Human Body Model
 - > 9.5 kV on D-, D+ pins only
 - > 4 kV on all other pins
- Space saving 14-terminal MLP package

Ordering Code:

Order Number	Package Number	Package Description
USB1T20MPX (Preliminary)	MLP14D	14-Terminal Molded Leadless Package (MLP), 2.5mm Square
USB1T20MTC (Note 1)	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

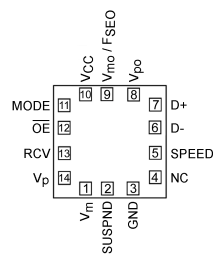
Note 1: Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Diagram



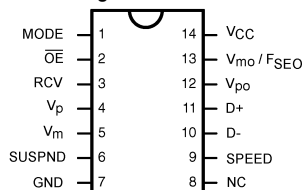
Connection Diagrams

Terminal Assignments for MLP (Preliminary)



(Top View)

Pin Assignments for TSSOP



(Top View)

Terminal and Pin Descriptions

Terminal or Pin Name	Terminal or Pin Number		I/O	Description
	MLP14D	MTC14		
RCV	13	3	O	Receive data. CMOS level output for USB differential input
$\overline{\text{OE}}$	12	2	I	Output Enable. Active LOW, enables the transceiver to transmit data on the bus. When not active the transceiver is in receive mode.
MODE	11	1	I	Mode. When left unconnected, a weak pull-up transistor pulls it to V_{CC} and in this GND, the V_{mo}/F_{SEO} pin takes the function of F_{SEO} (Force SEO).
V_{po} , V_{mo}/F_{SEO}	8, 9	12, 13	I	Inputs to differential driver. (Outputs from SIE).
				MODE V_{po} V_{mo}/F_{SEO} RESULT
				0 0 0 Logic "0"
				0 0 1 $\overline{\text{SEO}}$
				1 1 0 Logic "1"
				1 1 1 $\overline{\text{SEO}}$
				1 0 0 $\overline{\text{SEO}}$
				0 0 1 Logic "0"
				1 1 0 Logic "1"
				1 1 1 Illegal code
V_p , V_m	14, 1	4, 5	O	Gated version of D+ and D-. Outputs are logic "0" and logic "1". Used to detect single ended zero ($\overline{\text{SEO}}$), error conditions, and interconnect speed. (Input to SIE).
				V_p V_m RESULT
				0 0 $\overline{\text{SEO}}$
				0 1 Low Speed
				1 0 Full Speed
				1 1 Error
D+, D-	7, 6	11, 10	A/I/O	Data+, Data-. Differential data bus conforming to the Universal Serial Bus standard.
SUSPND	2	6	I	Suspend. Enables a low power state while the USB bus is inactive. While the SUSPND pin is active it will drive the RCV pin to a logic "0" state. Both D+ and D- are 3-STATE.
SPEED	5	9	I	Edge rate control. Logic "1" operates at edge rates for "full speed". Logic "0" operates edge rates for "low speed".
V_{CC}	10	14	—	3.0V to 3.6V power supply
GND	3	7	—	Ground reference
NC	4	8		No Connect

Functional Truth Table

Input					I/O		Outputs			Result
Mode	V_{po}	V_{mo}/F_{SEO}	$\overline{\text{OE}}$	SUSPND	D+	D-	RCV	V_p	V_m	
0	0	0	0	0	0	1	0	0	1	Logic 0
0	0	1	0	0	0	0	U	0	0	$\overline{\text{SEO}}$
0	1	0	0	0	1	0	1	1	0	Logic 1
0	1	1	0	0	0	0	U	0	0	$\overline{\text{SEO}}$
1	0	0	0	0	0	0	U	0	0	$\overline{\text{SEO}}$
1	0	1	0	0	0	1	0	0	1	Logic 0
1	1	0	0	0	1	0	1	1	0	Logic 1
1	1	1	0	0	1	1	U	U	U	Illegal Code
X	X	X	1	0	Z	Z	U	U	U	D+/D- Hi-Z
X	X	X	1	1	Z	Z	U	U	U	D+/D- Hi-Z

X = Don't Care

Z = 3-STATE

U = Undefined State

Absolute Maximum Ratings(Note 2)

DC Supply Voltage (V_{CC})	-0.5V to +7.0V
DC Input Diode Current (I_{IK})	
$V_I < 0$	-50 mA
Input Voltage (V_I)	
(Note 3)	-0.5V to +5.5V
Input Voltage ($V_{I/O}$)	-0.5V to $V_{CC} + 0.5V$
Output Diode Current (I_{OK})	
$V_O > V_{CC}$ or $V_O < 0$	± 50 mA
Output Voltage (V_O)	
(Note 3)	-0.5V to $V_{CC} + 0.5V$
Output Source or Sink Current (I_O)	
V_P, V_M, RCV Pins	
$V_O = 0V$ to V_{CC}	± 15 mA
Output Source or Sink Current (I_O)	
D+/D- Pins	
$V_O = 0V$ to V_{CC}	± 50 mA
V_{CC} or GND Current (I_{CC}, I_{GND})	± 100 mA
Storage Temperature (T_{STO})	-60°C to +150°C

Recommended Operating Conditions

Supply Voltage V_{CC}	3.0V to 3.6V
Input Voltage (V_I)	0V to 5.5V
Input Range for AI/O ($V_{AI/O}$)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Ambient Temperature	
in Free Air (T_{AMB})	-40°C to +85°C

Note 2: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristic tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 3: The input and output voltage ratings may be exceeded if the input and output clamp current ratings are observed.

DC Electrical Characteristics (Digital Pins)

Over recommended range of supply voltage and operating free air temperature (unless otherwise noted). $V_{CC} = 3.0V$ to $3.6V$

Symbol	Parameter	Test Conditions	Limits			Unit
			Temperature = -40°C to +85°C			
			Min	Typ	Max	
Input Levels						
V _{IL}	LOW Level Input Voltage				0.8	V
V _{IH}	HIGH Level Input Voltage		2.0			V
Output Levels						
V _{OL}	LOW Level Output Voltage	I _{OL} = 4 mA			0.4	V
		I _{OL} = 20 μA			0.1	
V _{OH}	HIGH Level Output Voltage	I _{OH} = 4 mA	2.4			V
		I _{OH} = 20 μA	V _{CC} - 0.1			
Leakage Current						
I _L	Input Leakage Current	V _{CC} = 3.0 to 3.6			±5	μA
I _{CCFS}	Supply Current (Full Speed)	V _{CC} = 3.0 to 3.6			5	mA
I _{CCLS}	Supply Current (Low Speed)	V _{CC} = 3.0 to 3.6			5	mA
I _{CCQ}	Quiescent Current	V _{CC} = 3.0 to 3.6 V _{IN} = V _{CC} or GND			5	mA
I _{CCS}	Supply Current in Suspend	V _{CC} = 3.0 to 3.6; Mode = V _{CC}			10	μA

DC Electrical Characteristics (D+/D- Pins)Over recommended range of supply voltage and operating free air temperature (unless otherwise noted). $V_{CC} = 3.0V$ to $3.6V$

Symbol	Parameter	Test Conditions	Limits			Units
			Temperature = -40°C to +85°C			
			Min	Typ	Max	
Input Levels						
V _{DI}	Differential Input Sensitivity	(D+) - (D-)	0.2			V
V _{CM}	Differential Common Mode Range	Includes V _{DI} Range	0.8		2.5	V
V _{SE}	Single Ended Receiver Threshold		0.8		2.0	V
Output Levels						
V _{OL}	Static Output LOW Voltage	R _L of 1.5 kΩ to 3.6V			0.3	V
V _{OH}	Static Output HIGH Voltage	R _L of 15 kΩ to GND	2.8		3.6	V
V _{CR}	Differential Crossover		1.3		2.0	V
Leakage Current						
I _{OZ}	High Z State Data Line Leakage Current	0V < V _{IN} < 3.3V			±5	μA
Capacitance						
C _{IN} (Note 5)	Transceiver Capacitance	Pin-to-GND			10	pF
	Capacitance Match				10	%
Output Resistance						
Z _{DRV} (Note 4)	Driver Output Resistance	Steady State Drive	4		20	Ω
	Resistance Match				10	%

Note 4: Excludes external resistor. In order to comply with USB Specification 1.1, external series resistors of $24\Omega \pm 1\%$ each on D+ and D- are recommended. This specification is guaranteed by design and statistical process distribution.**Note 5:** This specification is guaranteed by design and statistical process distribution.**AC Electrical Characteristics (D+/D- Pins, Full Speed)**

Over recommended range of supply voltage and operating free air temperature (unless otherwise noted).

 $V_{CC} = 3.0V$ to $3.6V$; $C_L = 50$ pF; $R_L = 1.5$ k Ω on D+ to V_{CC}

Symbol	Parameter	Test Condition	Limits			Units
			Temperature = -40°C to +85°C			
			Min	Typ	Max	
Driver Characteristics						
t _R	Rise Time	10% and 90% Figure 1	4		20	ns
t _F	Fall Time	Figure 1	4		20	
t _{RFM}	Rise/Fall Time Matching	(t _R /t _F)	90		110	%
V _{CRS}	Output Signal Crossover Voltage		1.3		2.0	V
Driver Timings						
t _{PLH}	Driver Propagation Delay	Figure 2			18	ns
t _{PLH}	(V _{p0} , V _{m0} /F _{SEO} to D+/D-)	Figure 2			18	ns
t _{PHZ}	Driver Disable Delay	Figure 4			13	ns
t _{PLZ}	($\overline{OE}$ to D+/D-)	Figure 4			13	ns
t _{PZH}	Driver Enable Delay	Figure 4			17	ns
t _{PZL}	($\overline{OE}$ to D+/D-)	Figure 4			17	ns
Receiver Timings						
t _{PLH}	Receiver Propagation Delay	Figure 3			16	ns
t _{PHL}	(D+, D- to RCV)	Figure 3			19	ns
t _{PLH}	Single-ended Receiver Delay	Figure 3			8	ns
t _{PHL}	(D+, D- to V _p , V _m)	Figure 3			8	ns

AC Electrical Characteristics (D+/D– Pins, Low Speed)

Over recommended range of supply voltage and operating free air temperature (unless otherwise noted).
 $V_{CC} = 3.0V$ to $3.6V$; $C_L = 200$ pF to 600 pF; $R_L = 1.5k\Omega$ on D– to V_{CC}

Symbol	Parameter	Test Conditions	Limits			Unit
			T _{AMB} = −40°C to +85°C			
			Min	Typ	Max	
Driver Characteristics						
t _{LR}	Rise Time	10% and 90% Figure 1	75		300	ns
t _{LF}	Fall Time	Figure 1	75		300	
t _{RFM}	Rise/Fall Time Matching	(t _R /t _F)	80		120	%
V _{CRS}	Output Signal Crossover Voltage		1.3		2.0	V
Driver Timings						
t _{PLH}	Driver Propagation Delay	Figure 2			300	ns
t _{PHL}	(V _{p0} , V _{m0} /F _{SE0} to D+/D−)	Figure 2			300	ns
t _{PHZ}	Driver Disable Delay	Figure 4			13	ns
t _{PLZ}	($\overline{OE}$ to D+/D−)	Figure 4			13	ns
t _{PZH}	Driver Enable Delay	Figure 4			205	ns
t _{PZL}	($\overline{OE}$ to D+/D−)	Figure 4			205	ns
Receiver Timings						
t _{PLH}	Receiver Propagation Delay	Figure 3			18	ns
t _{PHL}	(D+, D− to RCV)	Figure 3			18	ns
t _{PLH}	Single-ended Receiver Delay	Figure 3			28	ns
t _{PHL}	(D+, D− to V _p , V _m)	Figure 3			28	ns

AC Waveforms

V_{OL} and V_{OH} are the typical output voltage drops that occur with the output load. (V_{CC} never goes below 3.0V)

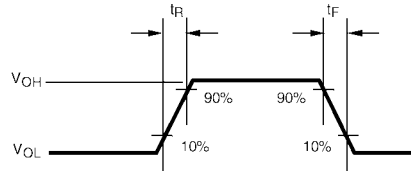


FIGURE 1. Rise and Fall Times

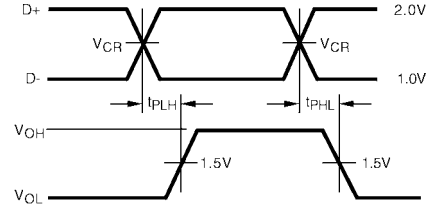


FIGURE 2. V_{pi} , V_{m0}/F_{SE0} to D+/D-

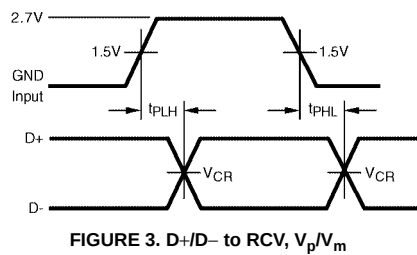


FIGURE 3. D+/D- to RCV, V_p/V_m

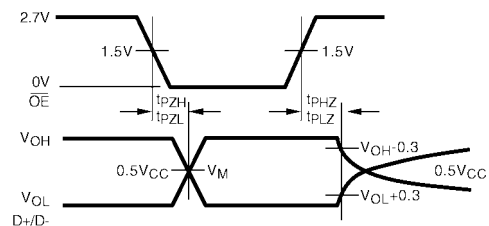
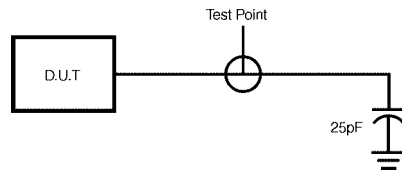
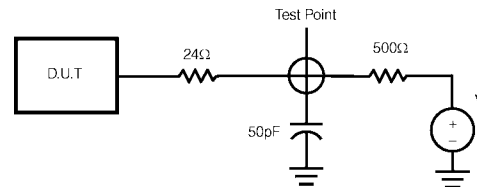


FIGURE 4. OE to D+/D-

Test Circuits and Waveforms



Load for V_m/V_p and RCV

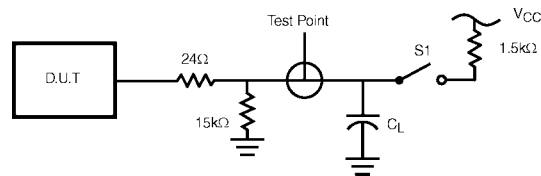


Load for Enable and Disable Times

Note:

$V = 0$ for t_{PZH} , t_{PHZ}

$V = V_{CC}$ for t_{PZL} , t_{PLZ}



Load for D+/D-

$C_L = 50$ pF, Full Speed

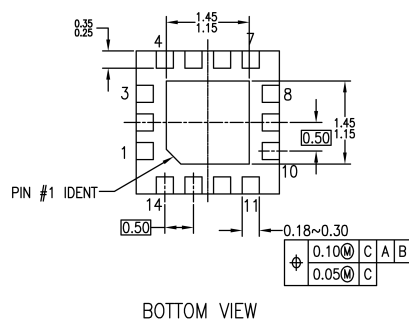
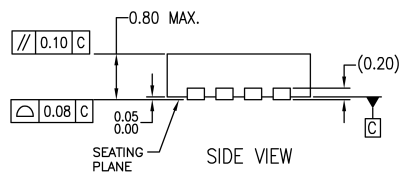
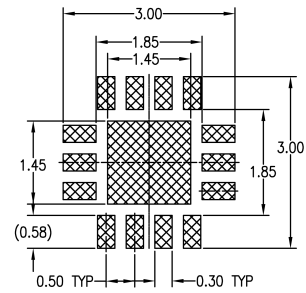
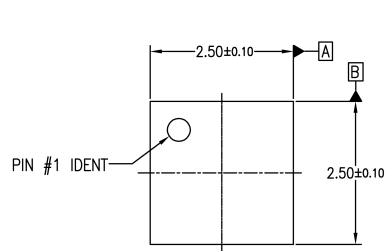
$C_L = 200$ pF, Low Speed (Minimum Timing)

$C_L = 600$ pF, Low Speed (Maximum Timing)

1.5 kΩ on D- (Low Speed) or D+ (Full Speed) only

Test	S1
D-/LS	Close
D+/LS	Open
D-/FS	Open
D+/FS	Close

Physical Dimensions inches (millimeters) unless otherwise noted



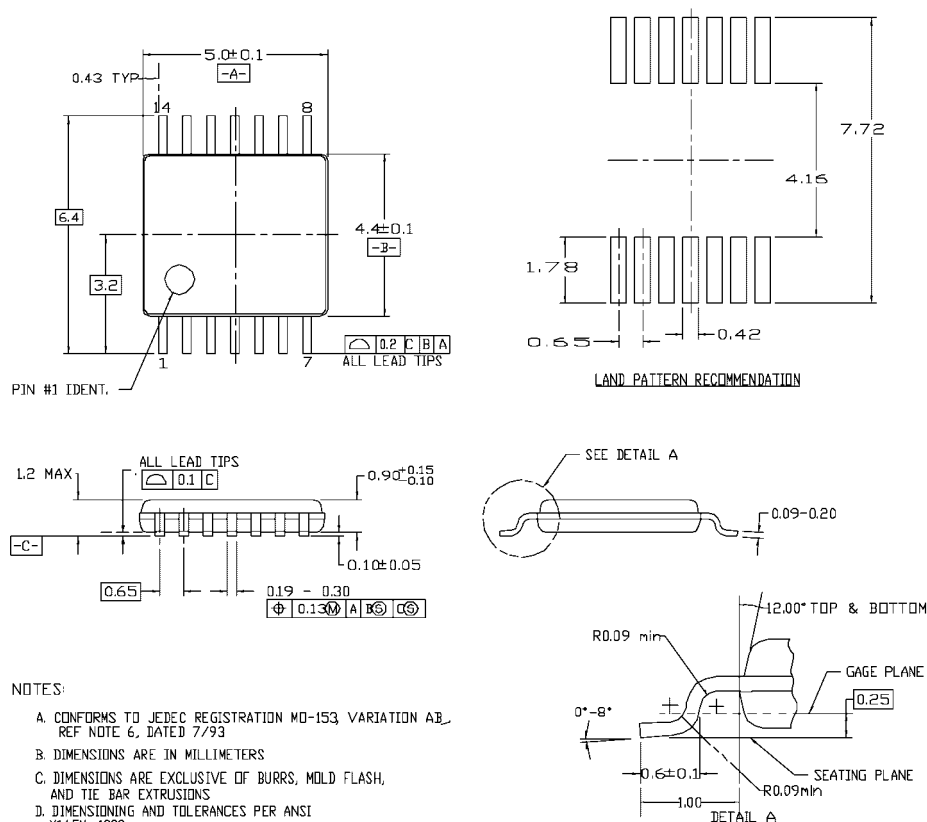
NOTES:

- NO JEDEC REGISTRATION
- DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

MLP14DrevA

**14-Terminal Molded Leadless Package (MLP), 2.5mm Square
Package Number MLP14D**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATED 7/93
- B. DIMENSIONS ARE IN MILLIMETERS
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS
- D. DIMENSIONING AND TOLERANCES PER ANSI Y14.5M, 1982

MTC14revD

14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC14

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